PTO/SB/08A (08-03)

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PER STRADEMAR INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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of 5 Sheet

	Complete If Known	`
Application Number	10/019,009	
Filing Date	April 26, 2002	
First Named Inventor	Victor B. Kley	
Art Unit	2881	
Examiner Name	T. Nguyen	
Attorney Docket Number	020921-000710US	

	U.S. PATENT DOCUMENTS+							
	<u> </u>	Document Number						
Examiner Initials*	Cite No.1	Number Kind Code ² (# known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
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12-07-03 Examiner Signature Date Considered

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INFORMATION DISCLOSURE ATEMENT BY APPLICANT

	Complete if Known	
Application Number	10/019,009	_
Filing Date	April 26, 2002	_
First Named Inventor	Victor B. Kley	_
Art Unit	2881	_
Examiner Name	T. Nguyen	_
Attorney Docket Number	020921-000710US	

	(use as	many sheets as necessary)	Examine	r Name	T. Nguyen	
Shelfi at	2	of 5	Attorney	Docket Number	020921-0007	10US
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Date Considered Examiner Signature MULLEN 12-07-03

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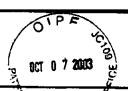
of 5

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Attorney Docket Number	020921-000710US	

			U.S. PATENT DO	CUMENTS+	
		Document Number	0.14	M-m- 4 8	Daniel California Linea Maria
Examiner Initials*	Cite No.1	Number Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Date Considered Examiner Signature le. 12-07-03 LOUYEN

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Sheet of 5

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Date Considered

12-07-03

PTO/SB/08B (08-03)

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary) Sheet 5 of 5

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Application Number	10/019,009				
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Examiner Initials *	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Т
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